IGBT - Field Stop, Trench 650 V, 50 A

Product Preview

FGHL50T65SQDT

Using novel field stop IGBT technology, ON Semiconductor's new series of field stop 4th generation IGBTs offer the optimum performance for solar inverter, UPS, welder, telecom, ESS and PFC applications where low conduction and switching losses are essential.

Features

- Maximum Junction Temperature : $T_J = 175$ °C
- Positive Temperature Co-efficient for Easy Parallel Operating
- High Current Capability
- Low Saturation Voltage: $V_{CE(Sat)} = 1.47 \text{ V (Typ.)} @ I_C = 50 \text{ A}$
- 100% of the Parts tested for I_{LM}(1)
- High Input Impedance
- Fast Switching
- Tighten Parameter Distribution
- This Device is Pb-Free and is RoHS Compliant

Typical Applications

• Solar Inverter, UPS, Welder, Telecom, ESS, PFC

Table 1. MAXIMUM RATING

Symbol	Rating	Value	Unit
V _{CES}	Collector to Emitter Voltage	650	V
V _{GES}	Gate to Emitter Voltage Transient Gate to Emitter Voltage	±20 ±30	V
I _C	Collector Current @ $T_C = 25^{\circ}C$ @ $T_C = 100^{\circ}C$	100 50	Α
I _{LM}	Pulsed Collector Current (Note 1)	200	Α
I _{CM}	Pulsed Collector Current (Note 2)	200	Α
IF	Diode Forward Current @ $T_C = 25^{\circ}C$ @ $T_C = 100^{\circ}C$	75 50	Α
I _{FM}	Pulsed Diode Maximum Forward Current	300	Α
P _D	Maximum Power Dissipation @ $T_C = 25^{\circ}C$ @ $T_C = 100^{\circ}C$	268 134	W
T _J , T _{STG}	Operating Junction / Storage Temperature Range	-55 to +175	°C
TL	Maximum Lead Temp. for Soldering Purposes, 1/8" from case for 5 seconds	265	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. VCC = 400 V, VGE = 15 V, IC = 200 A, R $\acute{\rm G}$ = 3 $\acute{\Omega}$, Inductive Load, 100% Tested 2. Repetitive rating: pulse width limited by max. Junction temperature

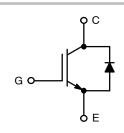
This document contains information on a product under development. ON Semiconductor reserves the right to change or discontinue this product without notice.

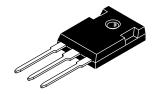


ON Semiconductor®

www.onsemi.com

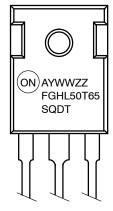
50 A, 650 V V_{CESat} = 1.47 V (Typ.)





TO-247-3LD CASE 340CX

MARKING DIAGRAM



FGHL50T65SQDT = Specific Device Code A = Assembly Location

Y = Year WW = Work Week

ZZ = Assembly Lot Number

ORDERING INFORMATION

Device	Package	Shipping
FGHL50T65SQDT	TO-247-3L	30 Units / Rail

THERMAL CHARACTERISTICS

Symbol	Rating	Value	Unit
$R_{ heta JC}$	Thermal Resistance, Junction to Case, for IGBT	0.56	°C/W
$R_{ heta JC}$	Thermal Resistance, Junction to Case, Max for Diode	0.65	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, Max	40	°C/W

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit		
OFF CHARA	OFF CHARACTERISTICS							
BV _{CES}	Collector-emitter breakdown voltage, gate-emitter short-circuited	V _{GE} = 0 V, I _C = 1 mA	650	_	_	V		
$\frac{\Delta BV_{CES}}{\Delta T_{i}}$	Temperature Coefficient of Breakdown Voltage	$V_{GE} = 0 \text{ V, } I_{C} = 1 \text{ mA}$	-	0.6	-	V/°C		
I _{CES}	Collector-emitter cut-off current, gate-emitter short-circuited	V _{GE} = 0 V, V _{CE} = V _{CES}	-	-	250	μΑ		
I _{GES}	Gate leakage current, collector-emitter short-circuited	V _{GE} = V _{GES} , V _{CE} = 0 V	1	-	±400	nA		
ON CHARAC	CTERISTICS							
V _{GE(th)}	Gate-emitter threshold voltage	$V_{GE} = V_{CE}$, $I_C = 50 \text{ mA}$	2.6	4.5	6.4	V		
V _{CE(sat)}	Collector-emitter saturation voltage	V _{GE} = 15 V, I _C = 50 A V _{GE} = 15 V, I _C = 50 A, T _C = 175°C	1 1	1.47 1.7	2.1 -	V		
DYNAMIC C	HARACTERISTICS							
C _{ies}	Input capacitance	V _{CE} = 30 V, V _{GE} = 0 V, f = 1 MHz	-	3081	-	pF		
C _{oes}	Output capacitance		-	136	-			
C _{res}	Reverse transfer capacitance		-	10.8	-			
SWITCHING	CHARACTERISTICS, INDUCTIVE LOAD							
t _{d(on)}	Turn-on delay time	T _C = 25°C VCC = 400 V, IC = 12.5 A	ı	22.8	-	ns		
t _r	Rise time	$Rg = 4.7 \Omega$	ı	5.20	-			
t _{d(off)}	Turn-off delay time	V _{GE} = 15 V Inductive Load	ı	70	-			
t _f	Fall time		ı	27.20	-			
E _{on}	Turn-on switching loss		ı	223	-	μJ		
Eo _{ff}	Turn-off switching loss		ı	91.13	-			
E _{ts}	Total switching loss		ı	314.13	-			
t _{d(on)}	Turn-on delay time	T _C = 25°C VCC = 400 V, IC = 25 A	-	23.60	-	ns		
t _r	Rise time	$Rg = 4.7 \Omega$	-	10.40	-			
t _{d(off)}	Turn-off delay time	V _{GE} = 15 V Inductive Load	-	66.40	-			
t _f	Fall time		-	10.20	-			
E _{on}	Turn-on switching loss		ı	515.60	-	μJ		
E _{off}	Turn-off switching loss		-	133	-			
E _{ts}	Total switching loss		-	648.60	_			

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted) (continued)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
SWITCHING	CHARACTERISTICS, INDUCTIVE LOAD	•	•			•
t _{d(on)}	Turn-on delay time	T _C = 175°C	_	23.60	-	ns
t _r	Rise time	VCC = 400 V, IC = 12.5 A Rg = 4.7 Ω	-	7.20	_	
t _{d(off)}	Turn-off delay time	V _{GE} = 15 V Inductive Load	-	87	-	
t _f	Fall time		-	72	-	
E _{on}	Turn-on switching loss		-	259.20	-	μJ
E _{off}	Turn-off switching loss		-	221	_	1
E _{ts}	Total switching loss		-	480.20	_	
t _{d(on)}	Turn-on delay time	T _C = 175°C	-	25.60	_	ns
t _r	Rise time	VCC = 400 V, IC = 25 A Rg = 4.7 Ω	-	14.80	-	
t _{d(off)}	Turn-off delay time	V _{GE} = 15 V Inductive Load	-	78	-	
t _f	Fall time	maddayo 25aa	-	42	-	
E _{on}	Turn-on switching loss		-	578.90	_	μJ
E _{off}	Turn-off switching loss		-	406.80	-	
E _{ts}	Total switching loss		-	985.70	-	
Qg	Total Gate Charge	VCE = 400 V, IC = 50 A,	-	99.7	_	nC
Qge	Gate to Emitter Charge	VGE = 15 V	-	18.3	_	nC
Qgc	Gate to collector Charge		-	25.90	_	nC
OODE CHA	RACTERISTICS	•	_			
V _F	Forward voltage	I _F = 50 A, T _c = 25°C I _F = 50 A, T _c = 175°C		2 1.6	2.6 -	V
Erec	Reverse Recovery Energy	I_F = 50 A, dI_F/dt = 200 A/ μ s, Tc =175°C	-	80.14	-	μJ
Trr	Diode Reverse Recovery Time	$\begin{array}{l} IF = 50 \text{ A, } dI_F/dt = 200 \text{ A}/\mu\text{s} \\ IF = 50 \text{ A, } dI_F/dt = 200 \text{ A}/\mu\text{s}, \\ Tc = 175^{\circ}C \end{array}$	-	35.60 201	-	nS
Qrr	Diode Reverse Recovery Charge	$\begin{array}{l} IF = 50 \text{ A, } dI_F/dt = 200 \text{ A}/\mu\text{s} \\ IF = 50 \text{ A, } dI_F/dt = 200 \text{ A}/\mu\text{s}, \\ Tc = 175^{\circ}\text{C} \end{array}$	-	66.22 1135.65	-	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS

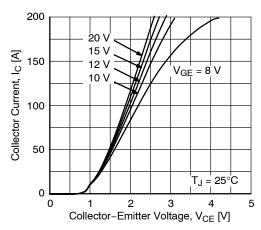


Figure 1. Typical Output Characteristics $(T_J = 25^{\circ}C)$

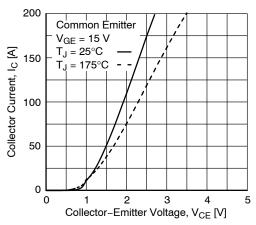


Figure 3. Typical Saturation Voltage Characteristics

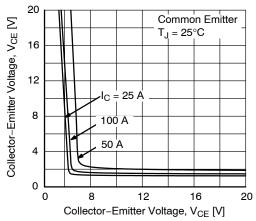


Figure 5. Saturation Voltage vs. V_{GE} ($T_J = 25^{\circ}C$)

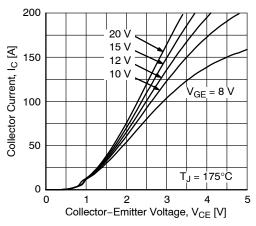


Figure 2. Typical Output Characteristics (T_J = 175°C)

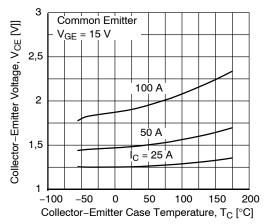


Figure 4. Saturation Voltage vs. Case Temperature at Variant Current Level

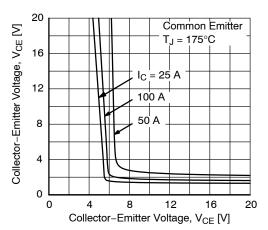


Figure 6. Saturation Voltage vs. V_{GE} ($T_{J} = 175^{\circ}C$)

TYPICAL CHARACTERISTICS (continued)

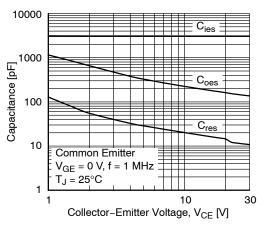


Figure 7. Capacitance Characteristics

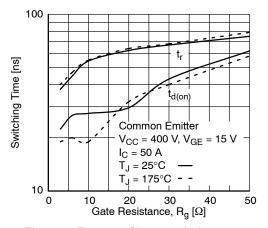


Figure 9. Turn-on Characteristics vs.
Gate Resistance

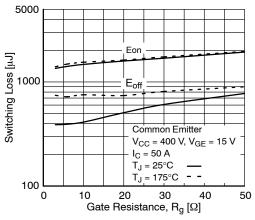


Figure 11. Switching Loss vs Gate Resistance

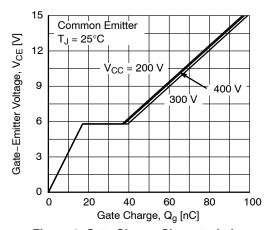


Figure 8. Gate Charge Characteristic

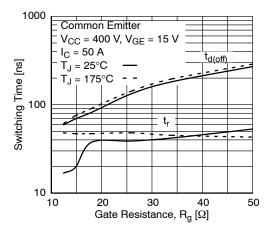


Figure 10. Turn-Off Characteristics vs.
Gate Resistance

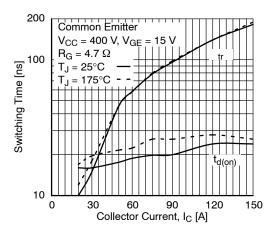


Figure 12. Turn-On Characteristics vs.
Collector Current

TYPICAL CHARACTERISTICS (continued)

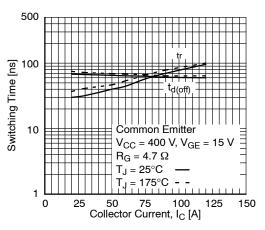


Figure 13. Turn-Off Characteristics vs. Collector Current

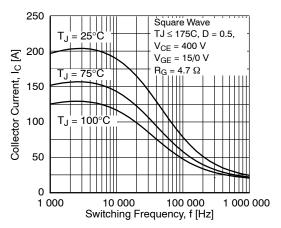


Figure 15. Load Current vs. Frequency

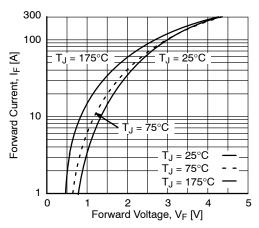


Figure 17. Forward Characteristics

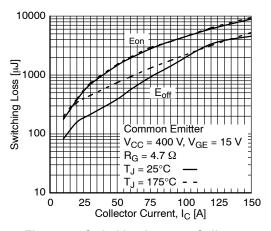


Figure 14. Switching Loss vs. Collector Current

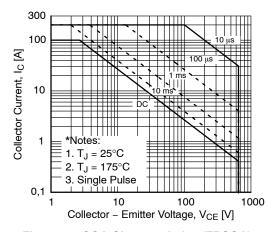


Figure 16. SOA Characteristics (FBSOA)

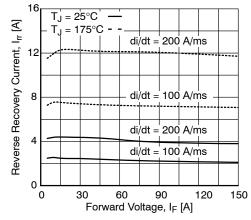


Figure 18. Reverse Recover Current

TYPICAL CHARACTERISTICS (continued)

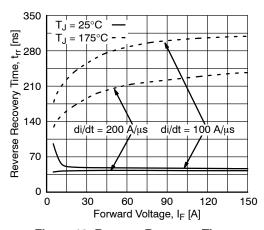


Figure 19. Reverse Recovery Time

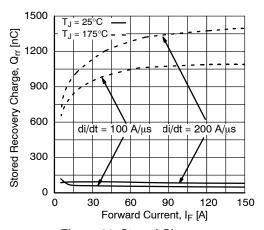


Figure 20. Stored Charge

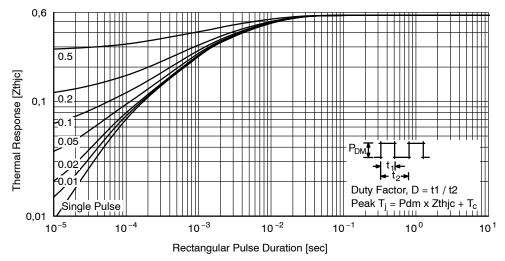


Figure 21. Transient Thermal Impedance of IGBT

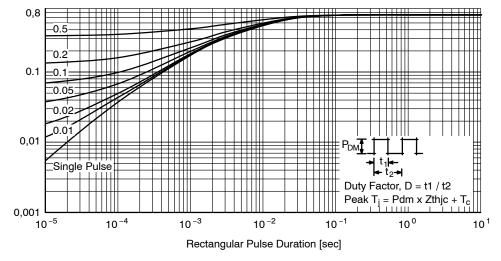
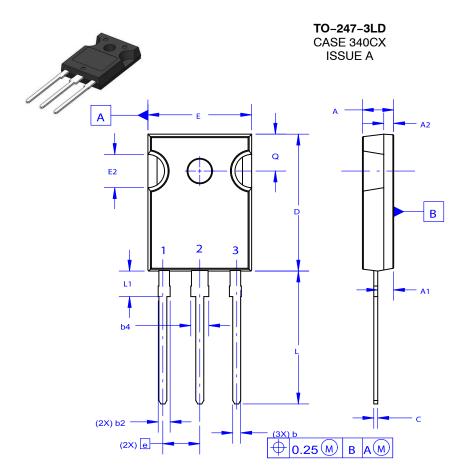
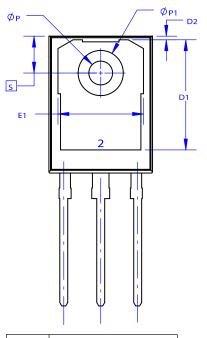


Figure 22. Transient Thermal Impedance of Diode



DATE 06 JUL 2020



NOTES: UNLESS OTHERWISE SPECIFIED.

- A. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.

 B. ALL DIMENSIONS ARE IN MILLIMETERS.
- C. DRAWING CONFORMS TO ASME Y14.5 2009.
- D. DIMENSION A1 TO BE MEASURED IN THE REGION DEFINED BY L1.
- E. LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY L1.

GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code = Assembly Location

= Year WW = Work Week G = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " =", may or may not be present. Some products may not follow the Generic Marking.

DIM	MIL	LIMETER	S
DIM	MIN	NOM	MAX
Α	4.58	4.70	4.82
A 1	2.20	2.40	2.60
A2	1.40	1.50	1.60
D	20.32	20.57	20.82
Е	15.37	15.62	15.87
E2	4.96	5.08	5.20
е	~	5.56	~
L	19.75	20.00	20.25
L1	3.69	3.81	3.93
ØΡ	3.51	3.58	3.65
Q	5.34	5.46	5.58
S	5.34	5.46	5.58
b	1.17	1.26	1.35
b2	1.53	1.65	1.77
b4	2.42	2.54	2.66
С	0.51	0.61	0.71
D1	13.08	~	~
D2	0.51	0.93	1.35
E1	12.81	~	~
ØP1	6.60	6.80	7.00

DOCUMENT NUMBER:	98AON93302G	Electronic versions are uncontrolled except when accessed directly from the Document Repository Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.		
DESCRIPTION:	TO-247-3LD		PAGE 1 OF 1	

ON Semiconductor and un are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.

onsemi, ONSEMi., and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. Onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any EDA class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer p

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT: Email Requests to: orderlit@onsemi.com

onsemi Website: www.onsemi.com

TECHNICAL SUPPORT North American Technical Support: Voice Mail: 1 800-282-9855 Toll Free USA/Canada Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support:

Phone: 00421 33 790 2910

For additional information, please contact your local Sales Representative